

FB16N50K-VB Datasheet

N-Channel 650V (D-S) Super Junction Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	650				
R _{DS(on)} at 25 °C (Ω)	V _{GS} = 10 V 0.23				
Q _g Typ. (nC)	24				
Q _{gs} (nC)	6				
Q _{gd} (nC)	11				
Configuration	Single				

FEATURES

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (C_{iss})
- Reduced switching and conduction losses
- Ultra low gate charge (Qg)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial
 - Welding
 - Induction heating
 - Motor drives
 - Battery chargers
 - Renewable energy
 - Solar (PV inverters)

ABSOLUTE MAXIMUM RATINGS ($T_C = 25 \text{ °C}$, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	650	V	
Gate-Source Voltage			V _{GS}	± 30		
Continuous Drain Current $(T_{1} - 150 ^{\circ}\text{C})$	V _{GS} at 10 V	T _C = 25 °C	- I _D	15		
Continuous Drain Current (T _J = 150 °C)		T _C = 100 °C		10	A	
Pulsed Drain Current ^a			I _{DM}	45		
Linear Derating Factor				1.4	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	286	mJ	
Maximum Power Dissipation			PD	180	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope T _J = 125 °C		dV/dt	37	V/ns		
Reverse Diode dV/dt d			23	v/ns		
Soldering Recommendations (Peak Temperature) ^c for 10 s			300	°C		

Notes

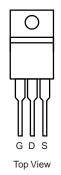
a. Repetitive rating; pulse width limited by maximum junction temperature.

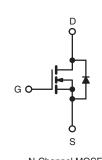
b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 28.2 mH, $R_g = 25 \Omega$, $I_{AS} = 4.5$ A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D, \, dI/dt = 100$ A/µs, starting $T_J = 25 \ ^\circ C.$

TO-220AB





N-Channel MOSFET





THERMAL RESISTANCE RATI	NGS								
PARAMETER	SYMBOL	TYP.		MAX.	MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-		62		0044			
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.7			- °C/W				
SPECIFICATIONS (T _J = 25 °C, ι	Inless otherwi	se noted)							
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT		
Static					-	-			
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D =	250 µA	650	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	, I _D = 1 mA	-	0.75	-	V/°C	
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	2	-	4	V	
		,	$V_{GS} = \pm 20$) V	-	-	± 100	nA	
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 30) V	-	-	± 1	μA	
		V _{DS} = 650 V, V _{GS} = 0 V		_{as} = 0 V	-	-	1		
Zero Gate Voltage Drain Current	IDSS	V _{DS} = 520 V	/, V _{GS} = 0 \	V, T _J = 125 °C	-	-	10	μA	
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$ $I_D = 8 A$		-	0.23	-	Ω		
Forward Transconductance		V _{DS} = 30 V, I _D = 8 A		-	5.6	-	S		
Dynamic					1	1	<u> </u>	1	
Input Capacitance	C _{iss}	$\label{eq:VGS} \begin{array}{c} V_{GS}=0 \ V, \\ V_{DS}=100 \ V, \\ f=1 \ MHz \end{array}$		-	1640	-	pF		
Output Capacitance	C _{oss}			-	80	-			
Reverse Transfer Capacitance	C _{rss}			-	4	-			
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$V_{\rm DS}$ = 0 V to 520 V, $V_{\rm GS}$ = 0 V		-	63	-			
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	213	-			
Total Gate Charge	Qg	V _{GS} = 10 V I _D = 8 A, V _{DS} = 520 V		-	24	48	nC		
Gate-Source Charge	Q _{gs}			-	6	-			
Gate-Drain Charge	Q _{gd}				-	11	-		
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 520 \text{ V}, \text{ I}_D = 8 \text{ A},$ $V_{GS} = 10 \text{ V}, \text{ R}_g = 9.1 \Omega$		-	18	36			
Rise Time	t _r			-	24	48	ns		
Turn-Off Delay Time	t _{d(off)}			-	48	96			
Fall Time	t _f			-	25	50			
Gate Input Resistance	R _g	t = 1	MHz, ope	n drain	-	0.8	-	Ω	
Drain-Source Body Diode Characteristic	cs						[
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	15	A		
Pulsed Diode Forward Current	I _{SM}			-	-	38			
Diode Forward Voltage	V _{SD}	$T_{J} = 25 \text{ °C}, I_{S} = 8 \text{ A}, V_{GS} = 0 \text{ V}$		-	-	1.2	V		
Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = I _S = 8 A, dl/dt = 100 A/ μ s, V _R = 400 V		-	325	-	ns		
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Reverse Recovery Charge	Q _{rr}	ے = 2 -11/-14	$5 \text{C}, 1_{\text{F}} = 1$	$I_{S} = 0 A,$	-	4.6	-	μC	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

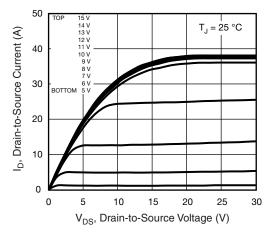


Fig. 1 - Typical Output Characteristics

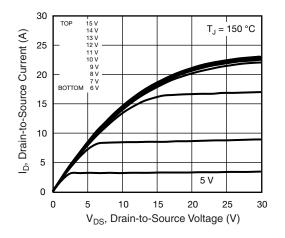


Fig. 2 - Typical Output Characteristics

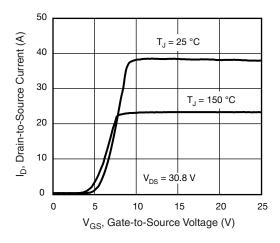


Fig. 3 - Typical Transfer Characteristics

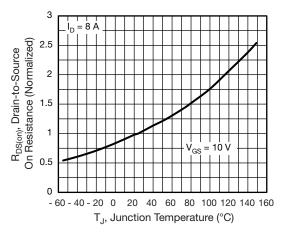


Fig. 4 - Normalized On-Resistance vs. Temperature

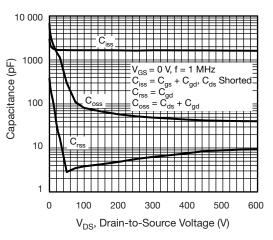


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

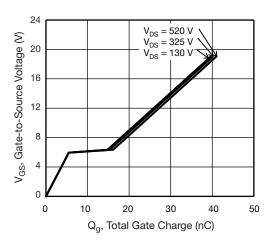


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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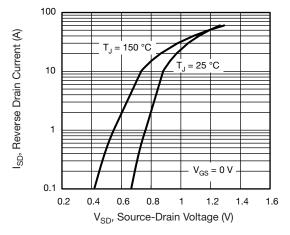


Fig. 7 - Typical Source-Drain Diode Forward Voltage

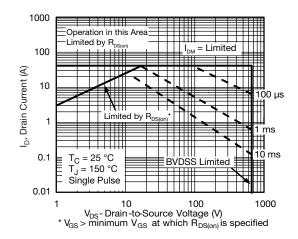


Fig. 8 - Maximum Safe Operating Area

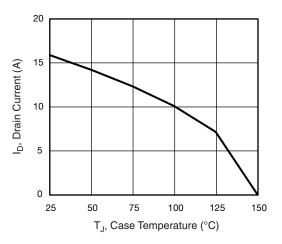


Fig. 9 - Maximum Drain Current vs. Case Temperature

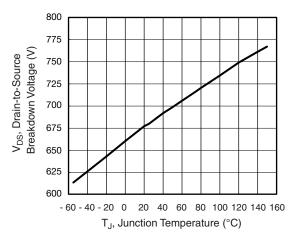


Fig. 10 - Temperature vs. Drain-to-Source Voltage

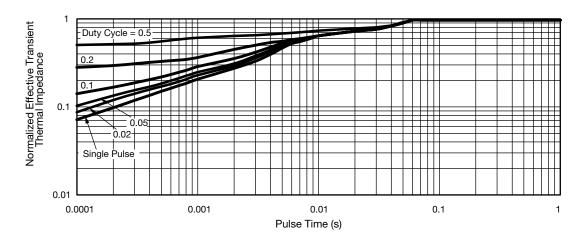


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



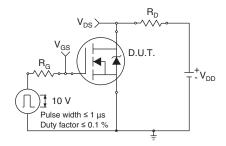


Fig. 12 - Switching Time Test Circuit

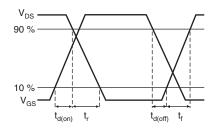


Fig. 13 - Switching Time Waveforms

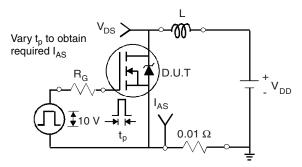


Fig. 14 - Unclamped Inductive Test Circuit

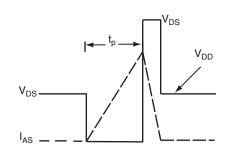


Fig. 15 - Unclamped Inductive Waveforms

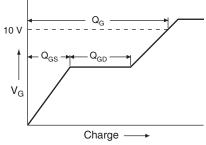


Fig. 16 - Basic Gate Charge Waveform

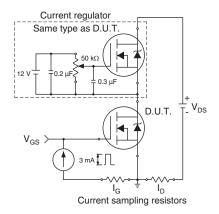
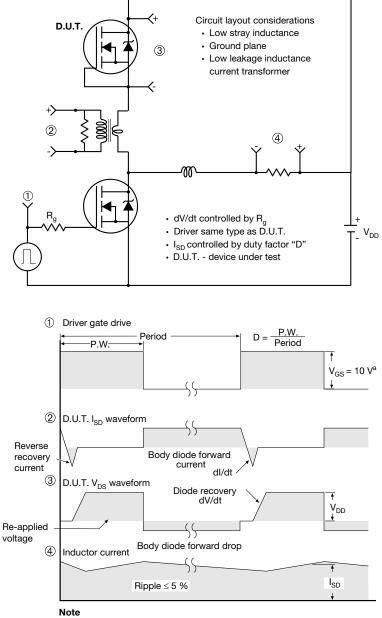


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

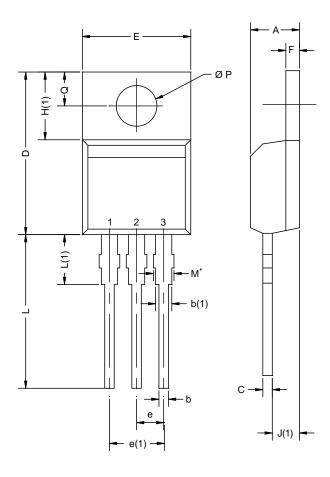


a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



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	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØΡ	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

Notes

 * M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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